

Issue Classification			Application/Control No.			Applicant(s)/Patent under Reexamination		
			09/834,689			SAH, ADAM D.		
			Examiner Sargon N. Nano			Art Unit 2157		

ORIGINAL				CROSS REFERENCE(S)					
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
709		240		709	227	231	239		
INTERNATIONAL CLASSIFICATION									
G	0	6	F	15/173					
				/					
				/					
				/					
				/					
 Sargon Nano (Assistant Examiner) (Date)				 ERIC ETIENNE PRIMARY EXAMINER (Primary Examiner)  R. W. Brown (Legal Instruments Examiner) (Date)				Total Claims Allowed: 20	
								O.G. Print Claim(s) 1	O.G. Print Fig. 20

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R. 1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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7	16	37	67	97	127	157	187
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9	18	39	69	99	129	159	189
10	19	40	70	100	130	160	190
11	20	41	71	101	131	161	191
12	21	42	72	102	132	162	192
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15		45	75	105	135	165	195
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7	27	57	87	117	147	177	207
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